


<b>Search Notes</b>  	<b>Application/Control No.</b>  10562732	<b>Applicant(s)/Patent Under Reexamination</b>  KAUR ET AL.
	<b>Examiner</b>  Anthony Weier	<b>Art Unit</b>  1781

SEARCHED			
Class	Subclass	Date	Examiner
426	648, 656	9/29/10	AW
updated	previous search	3/11/10	AW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor S Earch	9/29/10	AW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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